

**Notice of References Cited**

Application/Control No.

10/562,156

Applicant(s)/Patent Under  
Reexamination  
IKENAKA ET AL.

Examiner

Evelyn A. Lester

Art Unit

2873

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,726,436	03-1998	Oka et al.	359/719
*	B	US-6,636,365	10-2003	Saito et al.	359/719
*	C	US-6,710,939	03-2004	Sakamoto, Katsuya	359/719
*	D	US-6,728,042	04-2004	Ota et al.	359/719
*	E	US-6,807,019	10-2004	Takeuchi et al.	359/742
*	F	US-6,856,471	02-2005	Totsuka et al.	359/719
*	G	US-7,106,525	09-2006	Takeuchi et al.	359/719
*	H	US-2001/0043407	11-2001	Saito, Shinichiro	359/721
*	I	US-2004/0120052	06-2004	Kikuchi et al.	359/719
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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